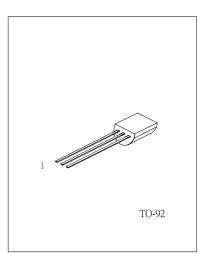
# SENSITIVE GATE SILICON **CONTROLLED RECTIFIERS** REVERSE BLOCKING **THYRISTORS**

#### **DESCRIPTION**

PNPN devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic TO-92 package which is readily adaptable for use in automatic insertion equipment.

#### DESCRIPTION

- \*Sensitive Gate Allows Triggering by Micro controllers and Other Logic circuits
- \*Blocking Voltage to 600V
- \*On-State Current Rating of 0.8A RMS at 80°C
- \*High Surge Current Capability 10A
- \*Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- \*Immunity to dV/dt 20V/µsec Minimum at 110°C
- \*Glass-Passivated Surface for Reliability and Uniformity



1: GATE 2: ANODE 3: CATHODE:

## THERMAL CHARACTERISTICS

| PARAMETER                               | SYMBOL                        | MAX | UNIT |  |
|---|-------------------------------|-----|------|--|
| Thermal Resistance, Junction to Case    | $R_{	heta JC}$                | 75  | °C/W |  |
| Thermal Resistance, Junction to Ambient | $R_{\scriptscriptstyle{0JA}}$ | 200 | °C/W |  |
| Lead Solder Temperature                 | $T_L$                         | 260 | °C   |  |
| (<1/16" from case, 10 secs max)         |                               |     |      |  |

### ABSOLUTE MAXIMUM RATINGS

| PARAMETER  | SYMBOL    | MAX | UNIT |
|--|-----------|-----|------|
| Peak Repetitive Off-State Voltage(note)                          | VDRM,VRRM |     | V    |
| (T <sub>J</sub> =-40 to 110°C, Sine Wave, 50 to 60Hz; Gate Open) |           |     |      |
| MCR101-4   |           | 200 |      |
| MCR101-6   |           | 400 |      |
| MCR101-8   |           | 600 |      |
| On-Sate RMS Current  | IT(RMS)   | 0.8 | Α    |
| (Tc=80°C) 180° Condition Angles                                  |           |     |      |
| Peak Non-Repetitive Surge Current                                | ITSM      | 10  | Α    |
| (1/2 cycle, Sine Wave, 60Hz, T <sub>J</sub> =25°C)               |           |     |      |

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| PARAMETER   | SYMBOL           | MAX         | UNIT             |
|---|------------------|-------------|------------------|
| Circuit Fusing Considerations                                     | l <sup>2</sup> t | 0.415       | A <sup>2</sup> s |
| (t=8.3 ms)  |                  |             |                  |
| Forward Peak Gate Power   | Рдм              | 0.1         | W                |
| (T <sub>A</sub> =25°C, Pulse Width ≤1.0μs)                        |                  |             |                  |
| Forward Average Gate Power  | PG(AV)           | 0.1         | W                |
| (T <sub>A</sub> =25°C, t=8.3ms)                                   |                  |             |                  |
| Peak Gate Current – Forward                                       | IGМ              | 1           | Α                |
| (T <sub>A</sub> =25°C, Pulse Width≤1.0μs)                         |                  |             |                  |
| Peak Gate Voltage – Reverse                                       | VGRM             | 5           | V                |
| (T <sub>A</sub> =25°C, Pulse Width≤1.0μs)                         |                  |             |                  |
| Operating Junction Temperature Range @ Rated V <sub>RRM</sub> and | TJ               | -40 to +110 | °C               |
| $V_{DRM}$   |                  |             |                  |
| Storage Temperature Range   | Tstg             | -40 to +150 | °C               |

Note:  $V_{DRM}$  and  $V_{RRM}$  for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

ELECTRICAL CHARACTERISTICS (Tj=25°C, unless otherwise stated)

| PARAMETER  | TEST CONDITION  | SYMBOL                              | MIN | TYP  | MAX        | UNIT                     |
|--|---|-------------------------------------|-----|------|------------|--------------------------|
| OFF CHARACTERISTICS  |   |                                     |     |      |            |                          |
| Peak Forward or Reverse Blocking<br>Current Tc=25°C<br>Tc=125°C        | $V_D\text{=}Rated~V_{DRM}$ and $V_{RRM};~R_{GK}\text{=}1k\Omega$                      | I <sub>DRM</sub> , I <sub>RRM</sub> |     |      | 10<br>100  | μ <b>Α</b><br>μ <b>Α</b> |
| ON CHARACTERISTICS   |   |                                     |     |      |            |                          |
| Peak Forward On-State Voltage (Note1)                                  | I <sub>TM</sub> =1A Peak @ T <sub>A</sub> =25°C                                       | $V_{TM}$                            |     |      | 1.7        | V                        |
| Gate Trigger Current (Continuous dc)(note2)                            | $V_{AK}$ =7Vdc, $R_L$ =100 $\Omega$ , $T_C$ =25°C                                     | I <sub>GT</sub>                     |     | 40   | 200        | μА                       |
| Holding Current (note 3) Tc=25 °C<br>Tc=-40 °C                         | V <sub>AK</sub> =7Vdc, initiating current=20mA  | l <sub>Η</sub>                      |     | 0.5  | 5<br>10    | mA                       |
| Latch Current Tc=25 °C Tc=-40 °C                                       | V <sub>AK</sub> =7V, Ig=200μA   | L                                   |     | 0.6  | 10<br>15   | mA                       |
| Gate Trigger Current<br>(continuous dc) (Note 2) Tc=25 °C<br>Tc=-40 °C | $V_{AK}$ =7Vdc, $R_L$ =100 $\Omega$   | $V_{GT}$                            |     | 0.62 | 0.8<br>1.2 | V                        |
| DYNAMIC CHARACTERISTICS  |   |                                     |     |      |            |                          |
| Critical Rate of Rise of Off-State<br>Voltage                          | $V_D$ =Rated $V_{DRM}$ , Exponential Waveform, $R_{GK}$ =1000 $\Omega$ , $T_J$ =110°C | dV/dt                               | 20  | 35   |            | V/μs                     |
| Critical Rate of Rise of On-State<br>Current                           | I <sub>PK</sub> =20A; Pw=10μsec;<br>diG/dt=1A/μsec, Igt=20mA                          | di/dt                               |     |      | 50         | A/μs                     |

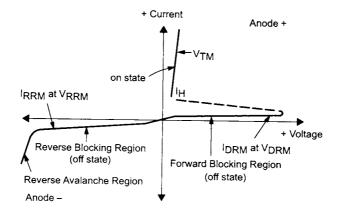
Notes: 1. Indicates Pulse Test Width≤1.0ms, duty cycle ≤1%

- 2.  $R_{GK}$ =1000 $\Omega$  included in measurement.
- 3. Does not include  $R_{\text{GK}}$  in measurement.

2

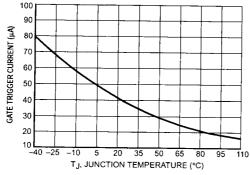
### **VOLTAGE CURRENT CHARACTERISTIC OF SCR**

| SYMBOL           | PARAMETER                                 |  |  |
|------------------|---|--|--|
| $V_{DRM}$        | Peak Repetitive Off Stat Forward Voltage  |  |  |
| I <sub>DRM</sub> | Peak Forward Blocking Current             |  |  |
| $V_{RRM}$        | Peak Repetitive Off State Reverse Voltage |  |  |
| I <sub>RRM</sub> | Peak Reverse Blocking Current             |  |  |
| $V_{TM}$         | Peak On State Voltage                     |  |  |
| I <sub>H</sub>   | Holding Current                           |  |  |



# CLASSIFICATION OF IGT

| RANK  | В        | С         | AA     | AB      | AC      | AD      |
|-------|----------|-----------|--------|---------|---------|---------|
| RANGE | 50-100μΑ | 100-200μΑ | 8-15μA | 15-20μΑ | 20-25μΑ | 25-50μΑ |



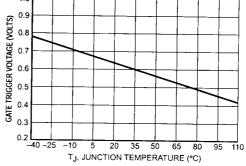
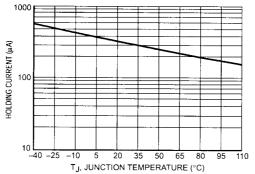


Figure 1. Typical Gate Trigger Current versus **Junction Temperature** 

Figure 2. Typical Gate Trigger Voltage versus **Junction Temperature** 



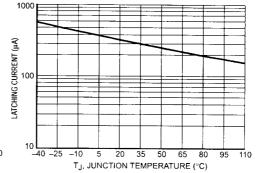
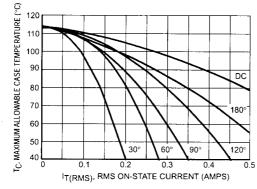


Figure 3. Typical Holding Current versus Junction Temperature

Figure 4. Typical Latching Current versus **Junction Temperature** 



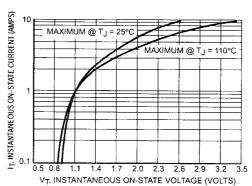


Figure 5. Typical RMS Current Derating

Figure 6. Typical On-State Characteristics

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